Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/552,811	BAIER ET AL.	
Examiner	Art Unit	
Hana A. Sanei	2879	

	SEARCHED			
Class	Subclass	Date	Examiner	
Updated	Previous Search	4/16/2007	HAS	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·	DATE	EXMR	
For text search see attached Search History	4/16/2007	HAS	
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